

**Search Notes**

Application/Control No.

10/809,411

Examiner

Justin Y. Lee

Applicant(s)/Patent under  
Reexamination

MORISAKI ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
Same	Previous Searches	8/29/2006	JL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/29/2006	JL
Duc Nguyen	8/30/2006	JL